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1 Introduction

Macromolecules are characterized by their long-chain structure, including molecular chain unit and con-
formation on angstrom scale, lamella on nanometer scale and spherulites on micron scale. Nowadays,
synchrotron radiation small angle X-ray scattering (SAXS) and wide angle X-ray diffraction (WAXD), as a
non-destructive, highly statistically averaged structure analysis method, have been widely used in crystalline
polymer research area. For instance, study information on grains in crystalline polymer, micro-domains in
blended polymers and the shape, size and distribution of cavities and cracks can be obtained by guinier
scattering. Study information on orientation, thickness and crystalline fraction of crystalline layer and the
thickness of amorphous layer of the lamella can be obtained by long-period measurement.

In order to further study the internal structure of polymers, two new test condition are required. Firstly,
considering the size of polymer spherulites, an X-ray spot with a size of $5\mu m \cdot 5\mu m$ is needed. A small spot
provides sufficient spatial resolution when the structure of macromolecules are characterized by the SAXS
method. Secondly, In order to match the detection result with the real structure, confirming the real-time
exact position of X-ray incident beam on polymer crystal is a critical measure.

To improve the spatial resolution of synchrotron radiation experiment, the world’s advanced synchrotron

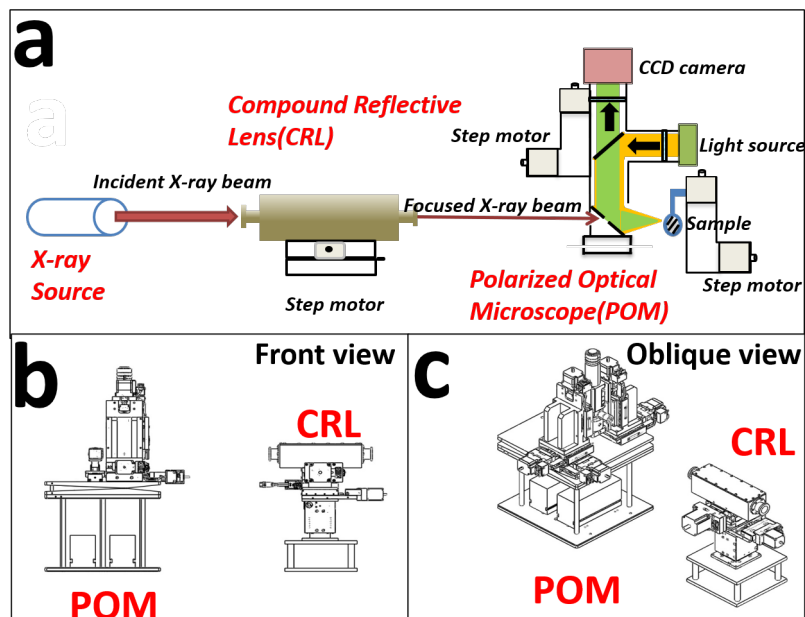


Fig. 1. Whole system

radiation light sources all use micro-focusing to focus the spot to the micron or even sub-micron level. Representative beamline stations include DSEY-PETRA III P03, SSRF BL15U1. However, limited by the distance between the sample and the detector, SAXS experiment can not be implemented on these stations.

The main components used for X-ray beam focusing are Kirkpatrick-Baez mirror, Fresnel zone plates, Capillary Optical Lens and Compound Refractive Lenses. In synchrotron radiation area, Kirkpatrick-Baez mirror(K-B mirror) and Compound Refractive Lenses(CRLs) are more widely used. The advantages of K-B mirror are aberration-free imaging on both horizontal and vertical planes, no dispersion, high energy, high reflectivity and low flux loss. However, there are some disadvantages which should be considered. K-B mirror micro-beam focusing needs to be achieved by adjusting the K-B two mirrors and multi-axis spatial attitude, including: the angle at which X-rays are incident on the mirrors, the vertical angle of the two mirrors, spatial parallelism of two vertical cylinders. The deployment of K-B mirror changes the original optical path. As a result, this off-axis device increases the complexity of installation of itself and other

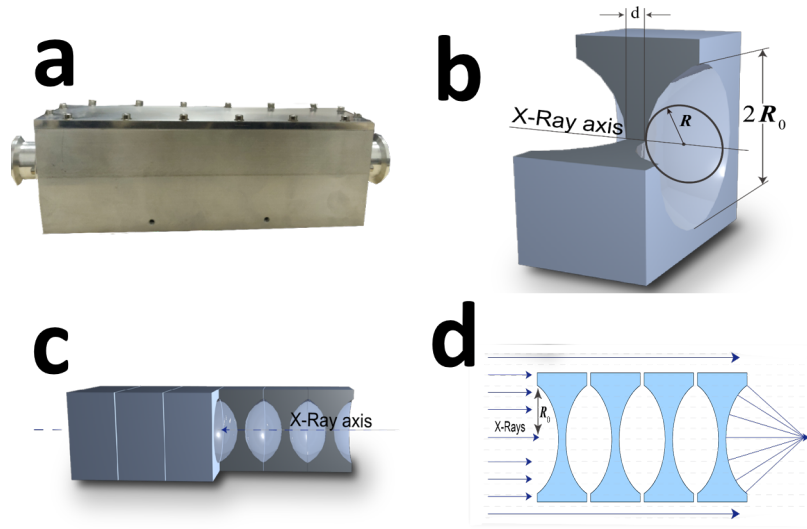


Fig. 2. Structure of Compound Reflective Lens

28 experimental equipment. This is unfavorable for the entire micro-focusing experiment process.

29 Compound Refractive Lenses(CRLs) are composed of a series of single lenses arranged in a linear array
 30 to achieve X-ray focusing in the energy range of 5-40 keV. As shown in Fig. 2, the most widely used CRLs
 31 are parabolic compound refraction lenses. The parabolic compound refraction lens has a parabolic surface
 32 that rotates around the axis of symmetry to form a parabola. It can focus X-rays in two dimensions without
 33 causing aberrations in theory. Compared to K-B mirror, CRL does not change the original optical path
 34 propagation direction, has good high temperature stability and easy cooling, simple and compact structure,
 35 easy to adjust, low requirements for lens surface roughness, relatively insensitive to vibration and many
 36 other advantages. The disadvantage of CRL is the low transmission efficiency. Because the aperture of the
 37 diaphragm is small and the X-rays are absorbed when they penetrate the lens material, the focused light
 38 intensity will drop by one to two orders of magnitude. Despite this, the luminous flux can be maintained at
 39 $10^{10} \sim 10^{11}$ phs/s after using CRL to focus the spot. This flux is enough to study the structure of crystalline
 40 polymers.

41 Polarized Optical Microscope(POM) is a simple and intuitive method for studying polymer crystal mor-

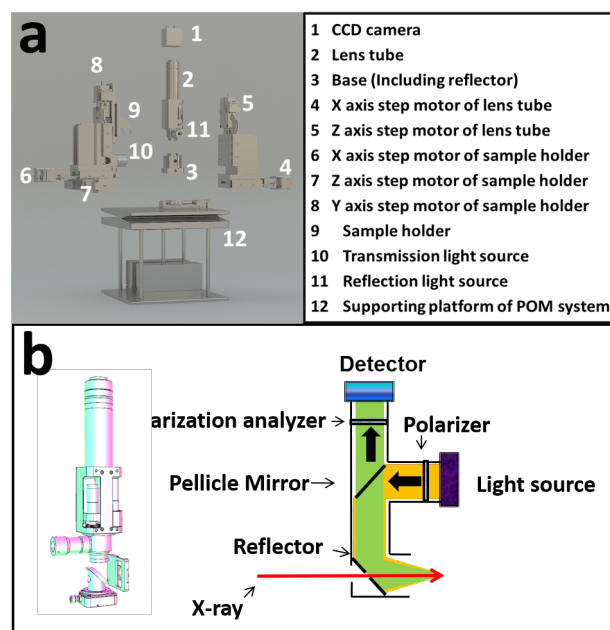


Fig. 3. POM overall disassembly and lens cone disassembly

phology. Fig. 3 is a schematic diagram of the disassembly of a POM. When the polarized light generated by the polarizer and the analyzer enters the anisotropic polymer crystal, birefringence occurs, and the crystal contrast is obtained through the coherence of the polarized light. Different crystal forms of polymers, such as spherulites, string crystals, stretched chain crystals, transverse crystals, etc., all have anisotropic optical properties, so their crystal morphology, size, number, etc. can be observed with a POM.

In this passage, a combined device of micro-focus synchrotron radiation small-angle scattering and polarizing microscope is proposed. A series of parameters of the device are adjusted, and the device is used to characterize the crystalline morphology and microstructure of related polymers.

Table. 1. Parameters of several common single lens

Radius $R/\mu\text{m}$	Aperture $2R_0/\mu\text{m}$	Area $\pi R_0^2/\text{mm}^{-2}$
200	881	0.609
100	623	0.305
50	440	0.152

2 Experiment

2.1 CRL parameter determination

CRL's parameter selection mainly includes its material, type and number of pieces. The energy of X-ray at BL19U2 is mainly 12 keV. In this energy, materials with low atomic number have less absorption of X-rays. For this reason, a beryllium CRL was chosen.

There are three common single lens, is the parameters of them. Considering the size of the lens container, lens with 50 μm was chosen.

According to the actual situation of beamline station shed size and pipeline layout. Transmittance refers to the ratio of the light intensity after passing through the lens and the light intensity without passing through the lens. It can be calculated by Eq. 1[1]:

$$T_p = \frac{\int_0^{2\pi} d\theta \int_0^{R_0} e^{-\mu N D(r)} r dr}{\int_0^{2\pi} d\theta \int_0^{R_0} r dr} = \frac{1 - e^{-a}}{a} e^{-\mu N d} \quad (1)$$

In Eq. 1, $a = \mu N R_0^2/R$, R and R_0 are given in Table 1, N is the number of lens; d is the minimum thickness of a single mirror. For parabolic lenses, d can be calculated with the following equation:

$$D(r) = d + 2 \times \frac{r^2}{2R} \quad (2)$$

The maximum processing thickness $D(r)$ of the CRL selected in this experiment is 2 mm. Substituting $D(r)$ and $r = R_0$ into the Eq. 2, the minimum d equals 1.032 mm.

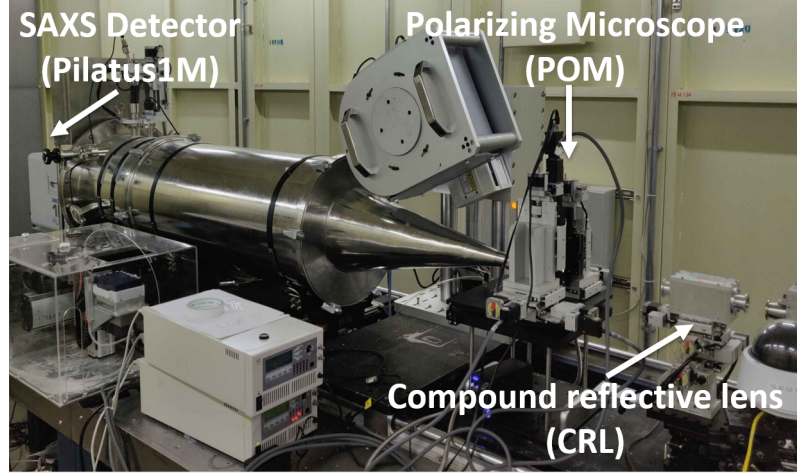


Fig. 4. Site map of the system

64 According to the actual situation of beamline station shed size and pipeline layout, the image distance
 65 is about 400 mm and so is the focal length. The focal length calculation formula under the approximate
 66 condition of thin lens is :

$$f = R/2N\delta \quad (3)$$

67 After a series of calculations, 30 is an appropriate number of lenses. Substituting $N = 30$ and $d = 1.032$ into
 68 the Eq. 1, T_p equals 0.327.

69 The flux of photons after passing through the lens can be calculated by the following equation:

$$I = i \times T_p \times R \quad (4)$$

70 i is the flux of incident X-ray. In BL19U2, under 220 mA current intensity, $i = 2.5 \times 10^{12}$ photons/s, R is
 71 the photon acceptance rate and equals 0.0598. Substituting these values into the Eq. 4, I equals 4.89×10^{10}
 72 photons/s. This value is enough to study the structure of crystalline polymers.

73 2.2 Construction of the joint system

74 Fig. 1 is the schematic diagram of the structure of synchrotron radiation X-ray micro-focusing polarized
75 microscopy system. The combined system includes a micro-focusing component and an in-situ polarized
76 light microscope system. After the incident X-ray is focused by the CRL, it will pass through the light hole
77 on the lower side of the POM, and then the scattered signal will be received by the detector. The on-site
78 construction diagram of the system is shown in Fig. 4.

79 The structure of POM used in the system is shown in Fig. 3.

80 As shown in Fig. 3b, the optical system of POM mainly consists of the following parts: a polarizer and
81 analyzer that use ordinary white light sources to generate polarized light; a half mirror located in the middle
82 of the lens barrel; a plane located below the lens barrel Reflecting mirror; at the top is the detector used to
83 collect images. In this system, the detector selects a CCD camera.

84 As shown in Fig. 3a, the in-situ POM system is installed on a motorized support platform. A step-
85 ping motor (4~5) installed on the side of the lens body realizes the translational adjustment of the lens
86 barrel in two dimensions. Similarly, the stepping motor (6~8) on the side of the sample holder realizes
87 its translational adjustment in three dimensions. The supporting platform (12) can be further divided into
88 three layers: the uppermost layer is a one-dimensional swing stage and a rotating table, the middle layer is
89 a two-dimensional (horizontal) translational electric platform, and the lowest layer is a three-dimensional
90 translational electric platform. Through the adjustment devices in all the above dimensions, The five spatial
91 dimensions of the entire optical system can be adjusted.

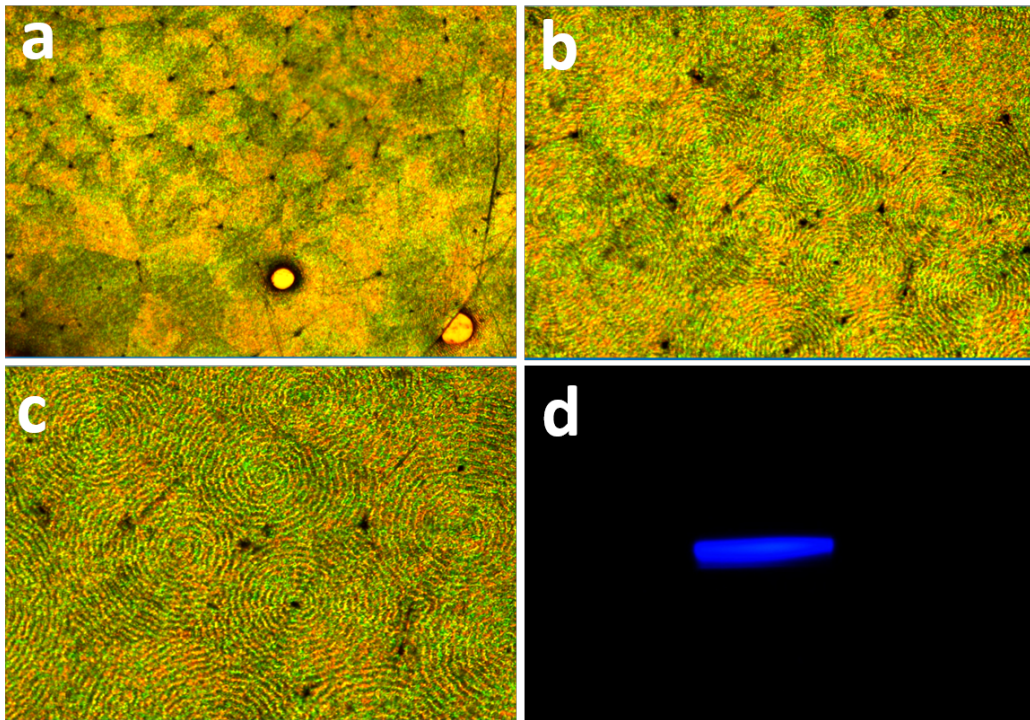


Fig. 5. Result of commissioning POM on site

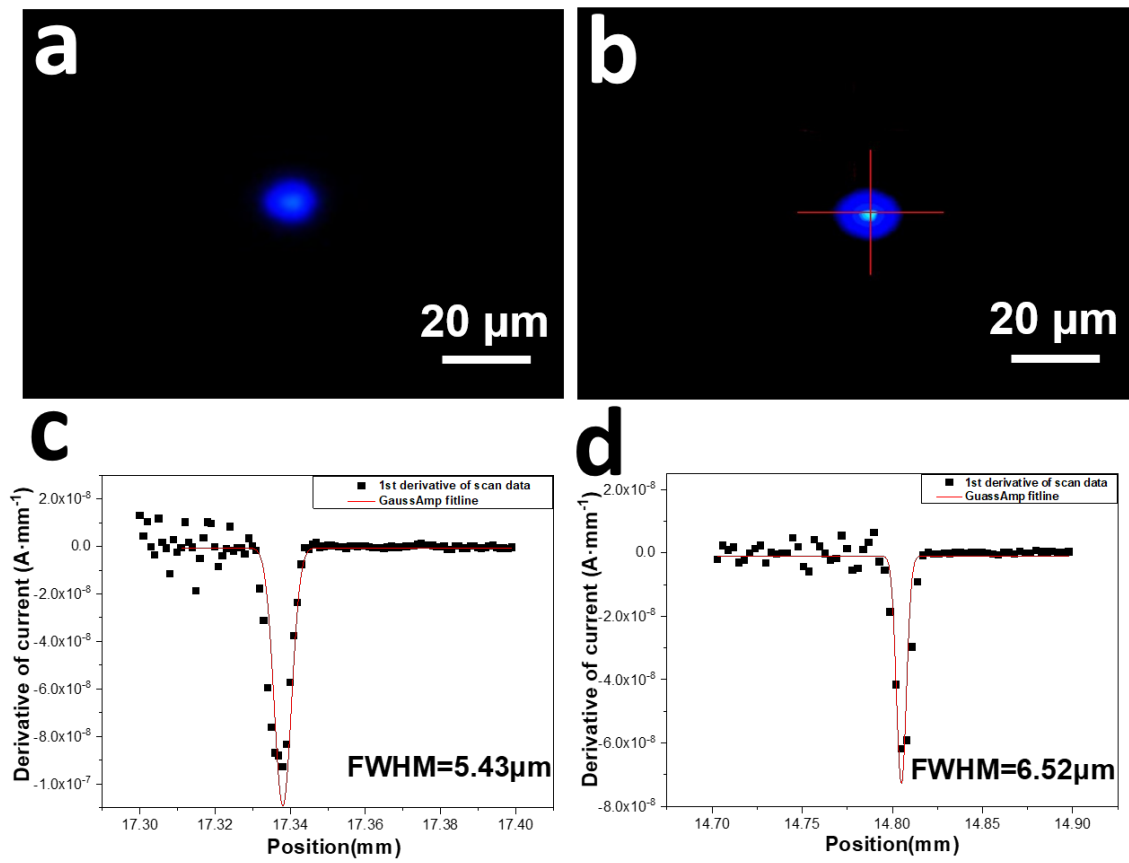


Fig. 6. Result of CRL microfocus X-ray diffraction (facula and flux)

92 **2.3 Determination of spot parameters**

93 **3 Application**

94 **References**

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